

# MOSFET - Power, Dual N-Channel 60 V, 27 mΩ, 21 A NVMJD027N06CL

### **Features**

- Small Footprint (5 x 6 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb-Free and are RoHS Compliant

### **MAXIMUM RATINGS** (T<sub>J</sub> = 25°C unless otherwise noted)

| Parameter   |                                     |                        | Symbol                            | Value          | Unit |
|---|-------------------------------------|------------------------|-----------------------------------|----------------|------|
| Drain-to-Source Voltage   |                                     |                        | $V_{DSS}$                         | 60             | ٧    |
| Gate-to-Source Voltage  |                                     |                        | V <sub>GS</sub>                   | ±20            | ٧    |
| Continuous Drain  |                                     | T <sub>C</sub> = 25°C  | I <sub>D</sub>                    | 21             | Α    |
| Current R <sub>θJC</sub> (Notes 1, 2, 3, 4)                                   | Steady<br>State                     | T <sub>C</sub> = 100°C |                                   | 15             |      |
| Power Dissipation   |                                     | T <sub>C</sub> = 25°C  | $P_{D}$                           | 24             | W    |
| R <sub>θJC</sub> (Notes 1, 2, 3)  |                                     | T <sub>C</sub> = 100°C |                                   | 12             |      |
| Continuous Drain  |                                     | T <sub>A</sub> = 25°C  | I <sub>D</sub>                    | 7.7            | Α    |
| Current R <sub>θJA</sub><br>(Notes 1, 3, 4)                                   | Steady                              | T <sub>A</sub> = 100°C |                                   | 5.5            |      |
| Power Dissipation   | State                               | T <sub>A</sub> = 25°C  | $P_{D}$                           | 3.2            | W    |
| R <sub>θJA</sub> (Notes 1, 3)   |                                     | T <sub>A</sub> = 100°C |                                   | 1.6            |      |
| Pulsed Drain Current  | $T_A = 25^{\circ}C, t_p = 10 \mu s$ |                        | I <sub>DM</sub>                   | 69             | Α    |
| Operating Junction and Storage Temperature Range                              |                                     |                        | T <sub>J</sub> , T <sub>stg</sub> | -55 to<br>+175 | °C   |
| Source Current (Body Diode)   |                                     |                        | Is                                | 20             | Α    |
| Single Pulse Drain-to-Source Avalanche<br>Energy (I <sub>L(pk)</sub> = 0.8 A) |                                     |                        | E <sub>AS</sub>                   | 57             | mJ   |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s)             |                                     |                        | TL                                | 260            | °C   |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

### THERMAL RESISTANCE MAXIMUM RATINGS (Note 1)

| Parameter                                   | Symbol          | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State (Note 3)    | $R_{\theta JC}$ | 6.28  | °C/W |
| Junction-to-Ambient - Steady State (Note 3) | $R_{\theta JA}$ | 46.6  |      |

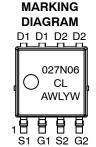
- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Psi  $(\Psi)$  is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to single case surface.
- 3. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- Continuous DC current rating. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

1

| V <sub>(BR)DSS</sub> | R <sub>DS(on)</sub> MAX | I <sub>D</sub> MAX |  |
|----------------------|-------------------------|--------------------|--|
| 60 V                 | 27 mΩ @ 10 V            | 21 A               |  |
|                      | 41 mΩ @ 4.5 V           | 21 A               |  |

# G1 O S1 G2 O S2





027N06CL = Specific Device Code A = Assembly Location

WL = Wafer Lot
 Y = Year
 W = Work Week

### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

# **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

| Parameter  | Symbol                                   | Test Condition   |                        | Min | Тур   | Max | Unit  |
|--|--|--|------------------------|-----|-------|-----|-------|
| OFF CHARACTERISTICS  | •  |  |                        |     |       |     |       |
| Drain-to-Source Breakdown Voltage                            | V <sub>(BR)DSS</sub>                     | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$                        |                        | 60  |       |     | V     |
| Drain-to-Source Breakdown Voltage<br>Temperature Coefficient | V <sub>(BR)DSS</sub> /<br>T <sub>J</sub> | $I_D$ = 250 $\mu$ A, ref to 25°C                                     |                        |     | 30.8  |     | mV/°C |
| Zero Gate Voltage Drain Current                              | I <sub>DSS</sub>                         | V <sub>GS</sub> = 0 V,   | T <sub>J</sub> = 25°C  |     |       | 10  | μΑ    |
|  |  | $V_{DS} = 60 \text{ V}$ $T_{J} = 125^{\circ}\text{C}$                | T <sub>J</sub> = 125°C |     |       | 100 | 1     |
| Gate-to-Source Leakage Current                               | I <sub>GSS</sub>                         | V <sub>DS</sub> = 0 V, V <sub>GS</sub> = +20 V                       |                        |     |       | 100 | nA    |
| ON CHARACTERISTICS (Note 5)                                  |  |  |                        |     |       |     |       |
| Gate Threshold Voltage                                       | V <sub>GS(TH)</sub>                      | $V_{GS} = V_{DS}, I_{D}$   | = 13 μΑ                | 1.2 |       | 2.2 | V     |
| Threshold Temperature Coefficient                            | V <sub>GS(TH)</sub> /T <sub>J</sub>      | I <sub>D</sub> = 13 μA, re   | to 25°C                |     | -5.95 |     | mV/°C |
| Drain-to-Source On Resistance                                | R <sub>DS(on)</sub>                      | V <sub>GS</sub> = 10 V,  | <sub>D</sub> = 9 A     |     | 23    | 27  | mΩ    |
|  |  | V <sub>GS</sub> = 4.5 V,   | I <sub>D</sub> = 9 A   |     | 33    | 41  | 7     |
| CHARGES AND CAPACITANCES                                     | •  |  |                        |     |       | •   | •     |
| Input Capacitance  | C <sub>iss</sub>                         | V <sub>GS</sub> = 0 V, f =   | 1.0 MHz,               |     | 335   |     | pF    |
| Output Capacitance   | C <sub>oss</sub>                         | $V_{DS} = 30$  | ) V                    |     | 153   |     | 7     |
| Reverse Transfer Capacitance                                 | C <sub>rss</sub>                         |  |                        |     | 4     |     | 1     |
| Total Gate Charge  | Q <sub>G(TOT)</sub>                      |  |                        |     | 5     |     | nC    |
| Threshold Gate Charge  | Q <sub>G(TH)</sub>                       | V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 48 V, I <sub>D</sub> = 9 A |                        |     | 0.3   |     | 1     |
| Gate-to-Source Charge  | Q <sub>GS</sub>                          |  |                        |     | 1     |     | 1     |
| Gate-to-Drain Charge   | $Q_{GD}$                                 |  |                        |     | 0.7   |     | 1     |
| SWITCHING CHARACTERISTICS (No                                | ote 6)                                   |  |                        |     |       |     | •     |
| Turn-On Delay Time   | t <sub>d(on)</sub>                       |  |                        |     | 6.8   |     | ns    |
| Rise Time  | t <sub>r</sub>                           | V <sub>GS</sub> = 4.5 V, V <sub>E</sub>                              | oe = 48 V.             |     | 6     |     |       |
| Turn-Off Delay Time  | t <sub>d(off)</sub>                      | I <sub>D</sub> = 9 A, R <sub>G</sub>                                 | $=6\Omega$             |     | 8.2   |     |       |
| Fall Time  | t <sub>f</sub>                           |  |                        |     | 3     |     | 1     |
| DRAIN-SOURCE DIODE CHARACTE                                  | RISTICS                                  |  |                        |     |       | •   |       |
| Forward Diode Voltage  | $V_{SD}$                                 | $V_{GS} = 0 V$ ,   | T <sub>J</sub> = 25°C  |     | 0.9   | 1.2 | V     |
| -  |  | I <sub>S</sub> = 9 A   | T <sub>J</sub> = 125°C |     | 0.8   |     | 7     |
| Reverse Recovery Time  | t <sub>RR</sub>                          | $V_{GS}$ = 0 V, $dI_S/dt$ = 100 A/ $\mu$ s, $I_S$ = 9 A              |                        |     | 17    |     | ns    |
| Charge Time  | t <sub>a</sub>                           |  |                        |     | 9     |     | 1     |
| Discharge Time   | t <sub>b</sub>                           |  |                        |     | 8     |     | 1     |
| Reverse Recovery Charge                                      | Q <sub>RR</sub>                          |  |                        |     | 7.0   |     | nC    |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.

6. Switching characteristics are independent of operating junction temperatures.

### **TYPICAL CHARACTERISTICS**

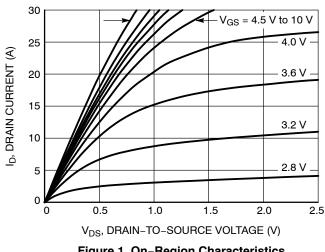


Figure 1. On-Region Characteristics

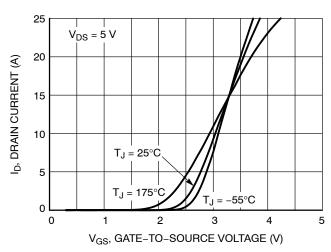


Figure 2. Transfer Characteristics

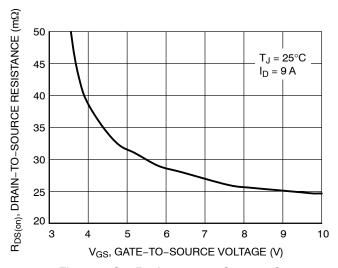


Figure 3. On-Resistance vs. Gate-to-Source Voltage

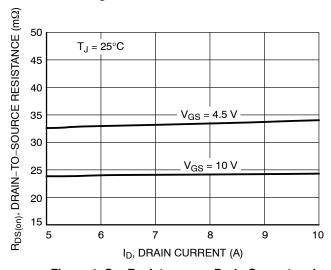


Figure 4. On-Resistance vs. Drain Current and **Gate Voltage** 

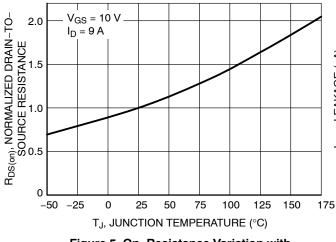


Figure 5. On-Resistance Variation with **Temperature** 

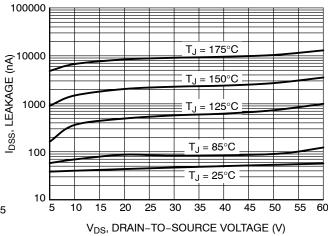


Figure 6. Drain-to-Source Leakage Current vs. Voltage

### **TYPICAL CHARACTERISTICS**

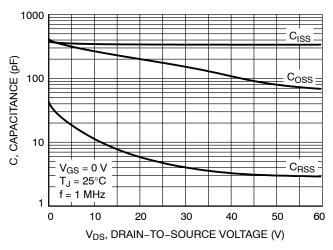


Figure 7. Capacitance Variation

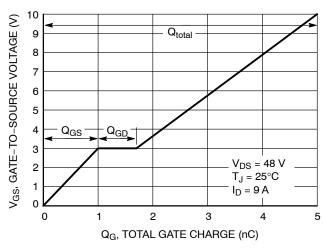


Figure 8. Gate-to-Source vs. Total Charge

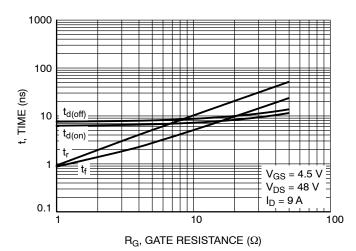


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

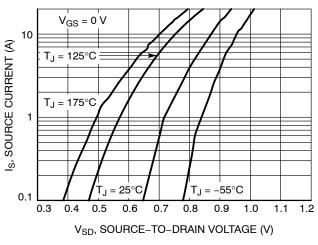


Figure 10. Diode Forward Voltage vs. Current

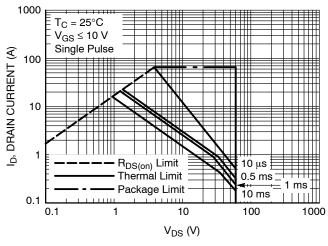


Figure 11. Maximum Rated Forward Biased Safe Operating Area

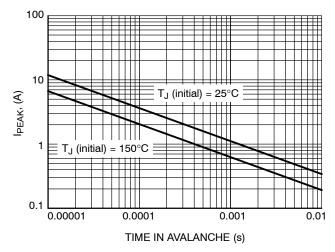


Figure 12.  $I_{\mbox{\scriptsize PEAK}}$  vs. Time in Avalanche

### **TYPICAL CHARACTERISTICS**

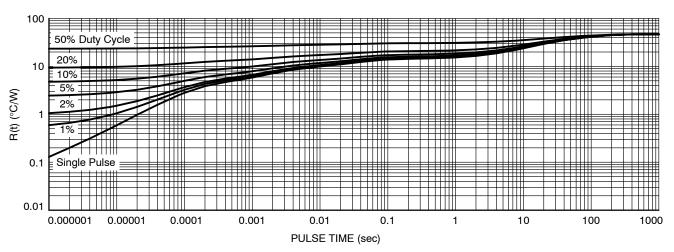


Figure 13. Thermal Characteristics

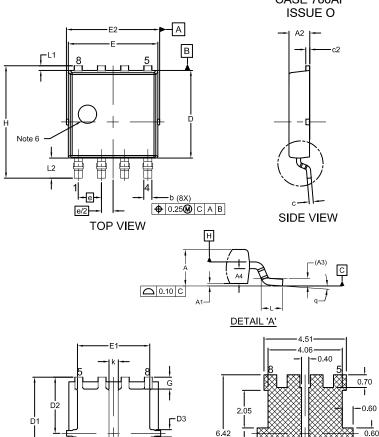
### **DEVICE ORDERING INFORMATION**

| Device           | Marking  | Package                  | Shipping <sup>†</sup> |
|------------------|----------|--------------------------|-----------------------|
| NVMJD027N06CLTWG | 027N06CL | LFPAK8 Dual<br>(Pb-Free) | 3000 / Tape & Reel    |

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

### PACKAGE DIMENSIONS

### **LFPAK8 5.15x6.15** CASE 760AF



# RECOMMENDED LAND PAD

0.70

\*FOR ADDITIONAL INFORMATION ON OUR PB-FREE STRATEGY AND SOLDERING DETAILS, PLEASE DOWNLOAD THE ON SEMICONDUCTOR SOLDERING AND MOUNTING TECHNIQUES REFERENCE MANUAL, SOLDERRM/D.

1.06

### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M. 1994.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH, PROTRUSIONS, OR BURRS. MOLD FLASH PROTRUSIONS OR GATE BURRS SHALL NOT EXCEED 0.150mm PER SIDE.
- 4. DIMENSIONS D AND E ARE DETERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 5. DATUMS A AND B ARE DETERMINED AT DATUM PLANE H.
- OPTIONAL MOLD FEATURE.

| MILLIMETERS |      |           |      |  |  |
|-------------|------|-----------|------|--|--|
| DIM         | MIN  | NOM       | MAX  |  |  |
| Α           | 1.10 | 1.20      | 1.30 |  |  |
| A1          | 0.00 | 0.08      | 0.15 |  |  |
| A2          | 1.10 | 1.15      | 1.20 |  |  |
| A3          | (    | ).25 REF  | =    |  |  |
| A4          | 0.45 | 0.50      | 0.55 |  |  |
| b           | 0.40 | 0.45      | 0.50 |  |  |
| С           | 0.19 | 0.22      | 0.25 |  |  |
| c2          | 0.19 | 0.22      | 0.25 |  |  |
| О           | 4.70 | 4.80      | 4.90 |  |  |
| D1          | 3.80 | 4.00      | 4.20 |  |  |
| D2          | 3.00 | 3.10      | 3.20 |  |  |
| D3          | 0.30 | 0.40      | 0.50 |  |  |
| Е           | 4.80 | 4.90      | 5.00 |  |  |
| E1          | 3.90 | 4.00      | 4.10 |  |  |
| E2          | 5.00 | 5.15      | 5.30 |  |  |
| е           | 1    | 1.270 BS  | C    |  |  |
| e/2         | (    | 0.635 BSC |      |  |  |
| G           | 0.55 | 0.65      | 0.75 |  |  |
| Н           | 6.00 | 6.15      | 6.30 |  |  |
| k           | 0.40 | 0.50      | 0.60 |  |  |
| L           | 0.45 | 0.65      | 0.85 |  |  |
| L1          | 0.15 | 0.25      | 0.35 |  |  |
| L2          | 0.90 | 1.10      | 1.30 |  |  |
| q           | 0°   | 4°        | 8°   |  |  |

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at <a href="www.onsemi.com/site/pdf/Patent-Marking.pdf">www.onsemi.com/site/pdf/Patent-Marking.pdf</a>. Onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using onsemi products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications provided by onsemi. "Typical" parameters which may be provided in onsemi data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. onsemi does not convey any license under any of its intellectual property rights nor the rights of others. onsemi products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer pu

### **PUBLICATION ORDERING INFORMATION**

8

**BOTTOM VIEW** 

LITERATURE FULFILLMENT:
Email Requests to: orderlit@onsemi.com

onsemi Website: www.onsemi.com

TECHNICAL SUPPORT North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support:

Phone: 00421 33 790 2910

For additional information, please contact your local Sales Representative